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Kind regards,

Team Nexperia

PH5330E

N-channel TrenchMOS logic level FET

Rev. 02 — 19 October 2009

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Higher operating power due to low thermal resistance
- Low conduction losses due to low on-state resistance

1.3 Applications

- DC-to-DC convertors
- Notebook computers

- Suitable for logic level gate drive sources
- Portable equipment
- Switched-mode power supplies

1.4	Quick reference data

Table 1. C	uick reference
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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	30	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V};$ see <u>Figure 1</u> and <u>3</u>	-	-	80	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	62.5	W
Dynamic	characteristics					
Q _{GD}	gate-drain charge	$V_{GS} = 5 \text{ V}; I_D = 20 \text{ A};$ $V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 11</u>	-	6	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 9}}{\text{Figure 9}} \text{ and } \frac{10}{10}$	-	4.8	5.7	mΩ



2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source	mb	
3	S	source		
4	G	gate	qj	
mb	D	mounting base; connected to drain	$\begin{array}{c} \hline \\ \hline \\ 1 \\ 2 \\ 3 \\ 4 \\ \end{array}$	mbb076 S
			SOT669 (LFPAK)	

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
PH5330E	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669		

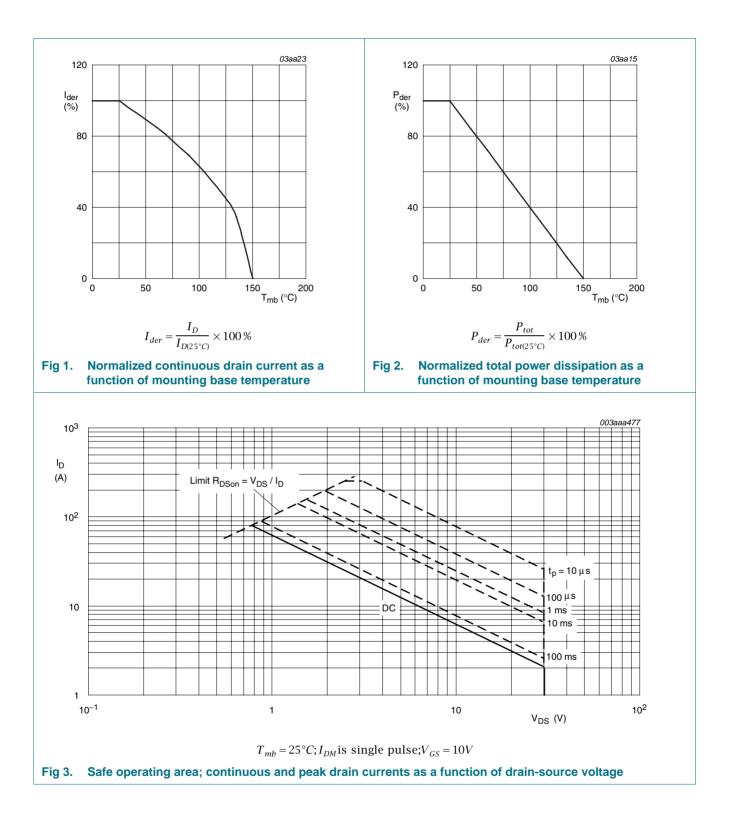
4. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	30	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 100 °C; see <u>Figure 1</u>	-	50.8	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> and <u>3</u>	-	80	А
I _{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3	-	250	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	62.5	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-di	rain diode				
I _S	source current	T _{mb} = 25 °C	-	52	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	208	А
Avalanch	e ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$V_{GS} = 10 \text{ V}; \text{ T}_{j(init)} = 25 \text{ °C}; \text{ I}_{D} = 36.2 \text{ A};$ $V_{sup} \leq 30 \text{ V};$ unclamped; $t_p = 0.15 \text{ ms}$	-	130	mJ

PH5330E



5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see <u>Figure 4</u>	-	-	2	K/W

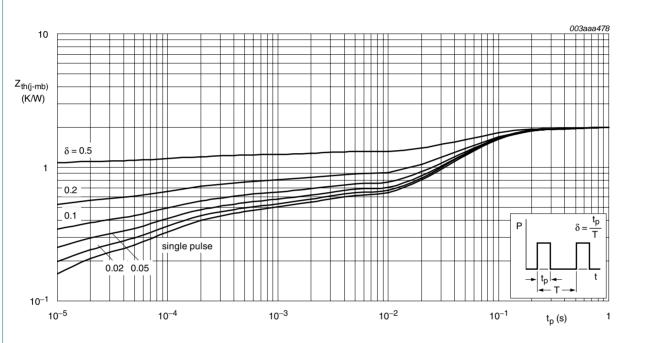
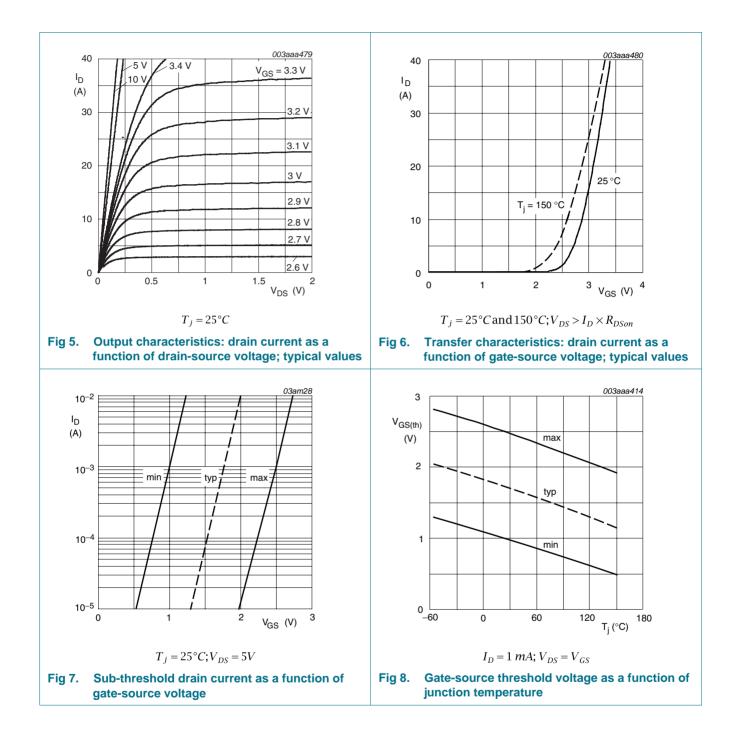


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

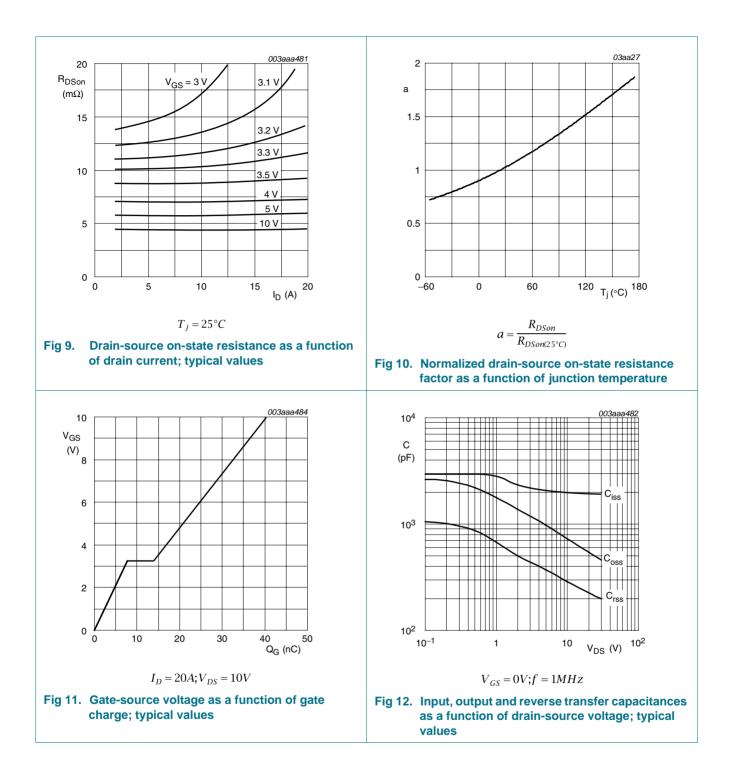
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
-	aracteristics	Conditions		ΥΡ	max	Onic
V _{(BR)DSS}	drain-source	I _D = 10 mA; V _{GS} = 0 V; T _i = 25 °C	30	-		V
• (BR)D33	breakdown voltage		00			v
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 150 °C; see <u>Figure 8</u>	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 8	1	1.7	2.5	V
I _{DSS}	drain leakage current	V_{DS} = 30 V; V_{GS} = 0 V; T_j = 25 °C	-	0.06	1	μA
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	500	μA
I _{GSS}	gate leakage current	V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25 °C	-	0.9	10	μA
		V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	0.9	10	μA
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 15 A; T_j = 25 °C; see <u>Figure 9</u> and <u>10</u>	-	4.8	5.7	mΩ
		V_{GS} = 4.5 V; I _D = 15 A; T _j = 25 °C	-	6.8	8.5	mΩ
		V _{GS} = 10 V; I _D = 15 A; T _j = 150 °C; see <u>Figure 9</u> and <u>10</u>	-	8.2	9.7	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 20 \text{ A}; V_{DS} = 10 \text{ V}; V_{GS} = 5 \text{ V};$	-	21	-	nC
Q _{GS}	gate-source charge	$T_j = 25 \text{ °C}; \text{ see } Figure 11$	-	8	-	nC
Q _{GD}	gate-drain charge		-	6	-	nC
C _{iss}	input capacitance	$V_{DS} = 10 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	2010	-	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 12$	-	732	-	pF
C _{rss}	reverse transfer capacitance		-	286	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 10 V; R_L = 0.7 Ω; V_{GS} = 10 V;	-	20	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \ \Omega; T_j = 25 \ ^{\circ}C; I_D = 14 \ A$	-	22	-	ns
t _{d(off)}	turn-off delay time		-	56	-	ns
t _f	fall time		-	13	-	ns
Source-di	rain diode					
V _{SD}	source-drain voltage	$I_S = 15 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 13</u>	-	0.8	1.2	V
t _{rr}	reverse recovery time	$\label{eq:ls} \begin{array}{l} I_{S} = 20 \; A; \; dI_{S}/dt = \text{-50 } A/\mu s; \; V_{GS} = 0 \; V; \\ V_{DS} = 25 \; V; \; T_{j} = 25 \; ^{\circ}C \end{array}$	-	53	-	ns
Qr	recovered charge	$I_S = 20 \text{ A}; \text{ dI}_S/\text{dt} -50 \text{ A}/\mu\text{s}; \text{ V}_{GS} = 0 \text{ V};$ $V_{DS} = 25 \text{ V}; \text{ T}_i = 25 \text{ °C}$	-	15	-	nC

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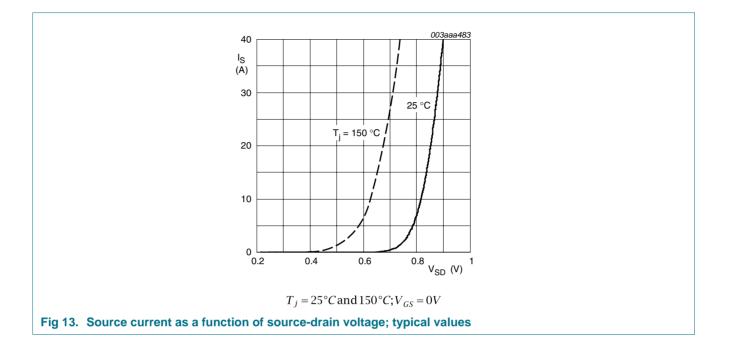


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N-channel TrenchMOS logic level FET



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7. Package outline

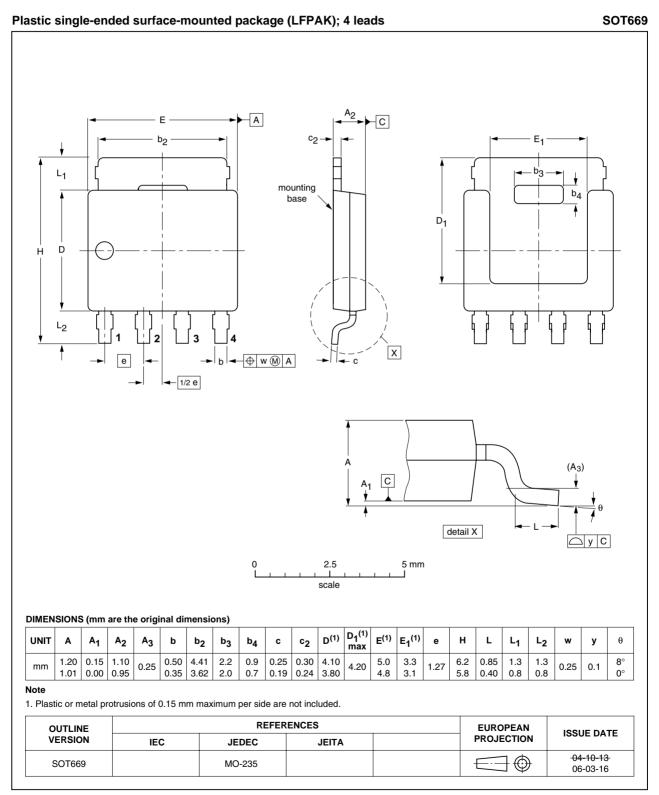


Fig 14. Package outline SOT669 (LFPAK)

8. Revision history

Table 7. Revisi	on history			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PH5330E_2	20091019	Product data sheet	-	PH5330E-01
Modifications: • The format of this data sheet has been redesigned to comply with the new identity guidelines NXP Semiconductors.				w identity guidelines of
	 Legal texts have be 	en adapted to the new com	npany name where approp	riate.
PH5330E-01 (9397 750 12334)	20040109	Product data	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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Date of release: 19 October 2009 Document identifier: PH5330E_2

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